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REVISIONS																			
LTR		DESCRIPTION						DATE (YR-MO-DA)			APPROVED								
А	Repla	Replaced reference to MIL-STD-973 with reference to MIL-				MIL-F	PRF-38	535r	rp	03-10-24			R. MONNIN						
В	Five	year re	eview re	quirem	entr	rp							12	-09-18			C. SA	AFFLE	
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PMIC N/A STANDARD			PREPARED BY RICK C. OFFICER CHECKED BY				DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990 http://www.landandmaritime.dla.mil												
DRA		G			CHAR	KLES E	. BESC	RE											
THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS		APPROVED BY AILABLE MICHAEL A. FRYE L S DRAWING APPROVAL DATE				MICROCIRCUIT, LINEAR, 10.0 VOLT, VOLTAGE REFERENCE, MONOLITHIC SILICON					E								
DEPARTMEN	NT OF I	DEFEN	ISE			89-1	1-16												
AM	SC N/A	L		REVI	SION	LEVEL	3			SI.	SIZE CAGE CODE 5962-89825			25					
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1.	SCOPE
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1.1 <u>Scope</u>. This drawing describes device requirements for MIL-STD-883 compliant, non-JAN class level B microcircuits in accordance with MIL-PRF-38535, appendix A.

1.2 Part or Identifying Number (PIN). The complete PIN is as shown in the following example:

<u>5962-89825</u>	<u>01</u>	<u>P</u>		A			
Drawing number	Device type (see 1.2.1)	Case outli (see 1.2.2	ne Lead 2) (see	d finish 1.2.3)			
1.2.1 <u>Device type(s)</u> . T	The device type(s) ider	ntify the circuit fur	nction as follow	s:			
Device type	Generic number	Circuit function	Vo	υт (V)	DV _{OUT} /dt (pp	om/°C)	
01 02 03	AD587SQ AD587TQ AD587UQ	10 V voltage ref 10 V voltage ref 10 V voltage ref	erence ±(ference ± erence ±(0.010 V 0.005 V 0.005 V	20 ppm/°C 10 ppm/°C 5 ppm/°C		
1.2.2 Case outline(s).	The case outline(s) ar	e as designated i	n MIL-STD-183	35 and as follo	WS:		
Outline letter	Descriptive des	signator	<u>Terminals</u>	Pa	<u>ckage style</u>		
Р	GDIP1-T8 or CI	DIP2-T8	8	D	ual-in-line		
1.2.3 Lead finish. The	lead finish is as specif	ied in MIL-PRF-3	8535, appendi	x A.			
1.3 Absolute maximum	<u>ratings</u> . <u>1</u> /						
Input voltage V _{IN} to Power dissipation (Storage temperatu Lead temperature (Thermal resistance Thermal resistance	(P_D) ground (P_D) re range (soldering, 10 seconds e, junction-to-case (θ_{JC} e, junction-to-ambient (;)) θJA)		+36 V 500 mW 65°C to + +300°C See MIL-S 110°C/W	150°C TD-1835		
1.4 Recommended ope	erating conditions.						
Ambient operating	temperature range (T ₄	A)		55°C to +	125°C		
$\underline{1}/T_{A} = +25^{\circ}C$ unless other	erwise noted.						
						[
ST MICROCI	FANDARD RCUIT DRAWING	i	A SIZE			5962	2-89825
DLA LAN COLUMBU	ID AND MARITIME S, OHIO 43218-3990			REVISION	LEVEL B	SHEET	2

2. APPLICABLE DOCUMENTS

2.1 <u>Government specification, standards, and handbooks</u>. The following specification, standards, and handbooks form a part of this drawing to the extent specified herein. Unless otherwise specified, the issues of these documents are those cited in the solicitation or contract.

DEPARTMENT OF DEFENSE SPECIFICATION

MIL-PRF-38535 - Integrated Circuits, Manufacturing, General Specification for.

DEPARTMENT OF DEFENSE STANDARDS

MIL-STD-883	-	Test Method Standard Microcircuits.
MIL-STD-1835	-	Interface Standard Electronic Component Case Outlines.

DEPARTMENT OF DEFENSE HANDBOOKS

MIL-HDBK-103 - List of Standard Microcircuit Drawings.

MIL-HDBK-780 - Standard Microcircuit Drawings.

(Copies of these documents are available online at https://assist.dla.mil/quicksearch/ or from the Standardization Document Order Desk, 700 Robbins Avenue, Building 4D, Philadelphia, PA 19111-5094.)

2.2 <u>Order of precedence</u>. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing takes precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

3. REQUIREMENTS

3.1 <u>Item requirements</u>. The individual item requirements shall be in accordance with MIL-PRF-38535, appendix A for non-JAN class level B devices and as specified herein. Product built to this drawing that is produced by a Qualified Manufacturer Listing (QML) certified and qualified manufacturer or a manufacturer who has been granted transitional certification to MIL-PRF-38535 may be processed as QML product in accordance with the manufacturers approved program plan and qualifying activity approval in accordance with MIL-PRF-38535. This QML flow as documented in the Quality Management (QM) plan may make modifications to the requirements herein. These modifications shall not affect form, fit, or function of the device. These modifications shall not affect the PIN as described herein. A "Q" or "QML" certification mark in accordance with MIL-PRF-38535 is required to identify when the QML flow option is used.

3.2 <u>Design, construction, and physical dimensions</u>. The design, construction, and physical dimensions shall be as specified in MIL-PRF-38535, appendix A and herein.

3.2.1 <u>Case outline</u>. The case outline shall be in accordance with 1.2.2 herein.

3.2.2 <u>Terminal connections</u>. The terminal connections shall be as specified on figure 1.

3.3 <u>Electrical performance characteristics</u>. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full ambient operating temperature range.

3.4 <u>Electrical test requirements</u>. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table I.

3.5 <u>Marking</u>. Marking shall be in accordance with MIL-PRF-38535, appendix A. The part shall be marked with the PIN listed in 1.2 herein. In addition, the manufacturer's PIN may also be marked.

3.5.1 <u>Certification/compliance mark</u>. A compliance indicator "C" shall be marked on all non-JAN devices built in compliance to MIL-PRF-38535, appendix A. The compliance indicator "C" shall be replaced with a "Q" or "QML" certification mark in accordance with MIL-PRF-38535 to identify when the QML flow option is used.

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	т	ABLE I. Electrical performance	e characteristic	<u>s</u> .			
Test	Symbol	$\begin{array}{c} Conditions \\ -55^{\circ}C \leq T_A \leq +125^{\circ}C \\ V_{IN} = 15 \ V \\ \text{unless otherwise specified} \end{array}$	Group A subgroups	Device type	Li	mits	Unit
					Min	Max	
Quiescent current	I _{CC}		1,2,3	All		4	mA
Output voltage error	V _{OUT}		1	All		10	mV
			12	02, 03		5	
Output voltage	DV _{OUT} /dt		2,3	01		20	ppm/°C
temperature coefficient				02		10	
				03		5	
Positive gain adjustment	V _{ADJ} +		1,2,3	All	+300		mV
Negative gain adjustment	V _{ADJ} -		1,2,3	All	-100		mV
Line regulation	V _{RLINE}		1,2,3	All		100	μV/V
Load regulation sourcing	V _{RLOAD}	$13.5~V \le V_{IN} \le 36~V$	1,2,3	All		100	μV/mA
Load regulation sinking	I _{OUT}	$I_{L} = -10 \text{ to } 0 \text{ mA}$	1,2,3	All		100	μV/mA
Output short circuit current	los	To GND	1	All		50	mA
			2,3	1		80	1
		To V _{IN}	1	1		50	1
			2,3]		80]

3.6 <u>Certificate of compliance</u>. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-HDBK-103 (see 6.6 herein). The certificate of compliance submitted to DLA Land and Maritime -VA prior to listing as an approved source of supply shall affirm that the manufacturer's product meets the requirements of MIL-PRF-38535, appendix A and the requirements herein.

3.7 <u>Certificate of conformance</u>. A certificate of conformance as required in MIL-PRF-38535, appendix A shall be provided with each lot of microcircuits delivered to this drawing.

3.8 <u>Notification of change</u>. Notification of change to DLA Land and Maritime -VA shall be required for any change that affects this drawing.

3.9 <u>Verification and review</u>. DLA Land and Maritime, DLA Land and Maritime's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

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Device types	01, 02, and 03
Case outline	Р
Terminal number	Terminal symbol
1	No connection
2	V _{IN}
3	No connection
4	GND
5	Trim
6	V _{OUT}
7	No connection
8	Noise reduction

FIGURE 1. Terminal connections.

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4. VERIFICATION

4.1 <u>Sampling and inspection</u>. Sampling and inspection procedures shall be in accordance with MIL-PRF-38535, appendix A.

4.2 <u>Screening</u>. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:

- a. Burn-in test, method 1015 of MIL-STD-883.
 - (1) Test condition A, B, C, or D. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to the preparing or acquiring activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1015 of MIL-STD-883.
 - (2) $T_A = +125^{\circ}C$, minimum.
- b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.

4.3 <u>Quality conformance inspection</u>. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.

- 4.3.1 Group A inspection.
 - a. Tests shall be as specified in table II herein.
 - b. Subgroups 4, 5, 6, 7, 8, 9, 10, and 11 in table I, method 5005 of MIL-STD-883 shall be omitted.
 - c. Optional subgroup 12 is used for grading and part selection at +25°C, it is not included in PDA.
- 4.3.2 Groups C and D inspections.
 - a. End-point electrical parameters shall be as specified in table II herein.
 - b. Steady-state life test conditions, method 1005 of MIL-STD-883.
 - (1) Test condition A, B, C, or D. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to the preparing or acquiring activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1005 of MIL-STD-883.
 - (2) $T_A = +125^{\circ}C$, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

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TABLE II.	Electrical test re	equirements.
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MIL-STD-883 test requirements	Subgroups
	(in accordance with
	MIL-STD-883, method 5005,
	table I)
Interim electrical parameters	1
(method 5004)	
Final electrical test parameters	1*, 2, 3, 12
(method 5004)	
Group A test requirements	1, 2, 3, 12
(method 5005)	
Groups C and D end-point	1
electrical parameters	
(method 5005)	

* PDA applies to subgroup 1.

5. PACKAGING

5.1 <u>Packaging requirements</u>. The requirements for packaging shall be in accordance with MIL-PRF-38535, appendix A.

6. NOTES

6.1 <u>Intended use</u>. Microcircuits conforming to this drawing are intended for use for Government microcircuit applications (original equipment), design applications, and logistics purposes.

6.2 <u>Replaceability</u>. Microcircuits covered by this drawing will replace the same generic device covered by a contractorprepared specification or drawing.

6.3 <u>Configuration control of SMD's</u>. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished using DD Form 1692, Engineering Change Proposal.

6.4 <u>Record of users</u>. Military and industrial users shall inform DLA Land and Maritime when a system application requires configuration control and the applicable SMD to that system. DLA Land and Maritime will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronics devices (FSC 5962) should contact DLA Land and Maritime -VA, telephone (614) 692-0544.

6.5 <u>Comments</u>. Comments on this drawing should be directed to DLA Land and Maritime -VA, Columbus, Ohio 43218-3990, or telephone (614) 692-0540.

6.6 <u>Approved sources of supply</u>. Approved sources of supply are listed in MIL-HDBK-103 and QML-38535. The vendors listed in MIL-HDBK-103 and QML-38535 have agreed to this drawing and a certificate of compliance (see 3.6 herein) has been submitted to and accepted by DLA Land and Maritime -VA.

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STANDARD MICROCIRCUIT DRAWING BULLETIN

DATE: 12-09-18

Approved sources of supply for SMD 5962-89825 are listed below for immediate acquisition information only and shall be added to MIL-HDBK-103 and QML-38535 during the next revision. MIL-HDBK-103 and QML-38535 will be revised to include the addition or deletion of sources. The vendors listed below have agreed to this drawing and a certificate of compliance has been submitted to and accepted by DLA Land and Maritime -VA. This information bulletin is superseded by the next dated revision of MIL-HDBK-103 and QML-38535. DLA Land and Maritime maintains an online database of all current sources of supply at http://www.landandmaritime.dla.mil/Programs/Smcr/.

Standard	Vendor	Vendor
microcircuit drawing PIN 1/	CAGE number	similar PIN 2/
	<u>3</u> /	AD587SQ/883B
5962-8982502PA	24355	AD587TQ/883B
5962-8982503PA	24355	AD587UQ/883B

- 1/ The lead finish shown for each PIN representing a hermetic package is the most readily available from the manufacturer listed for that part. If the desired lead finish is not listed contact the vendor to determine its availability.
- <u>2</u>/ <u>Caution</u>. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.
- $\underline{3}$ / Not available from an approved source of supply.

Vendor CAGE <u>number</u>

Vendor name and address

24355

Analog Devices Route 1 Industrial Park P.O. Box 9106 Norwood, MA 02062 Point of contact: 804 Woburn Street Wilmington, MA 01887-3462

The information contained herein is disseminated for convenience only and the Government assumes no liability whatsoever for any inaccuracies in the information bulletin.